

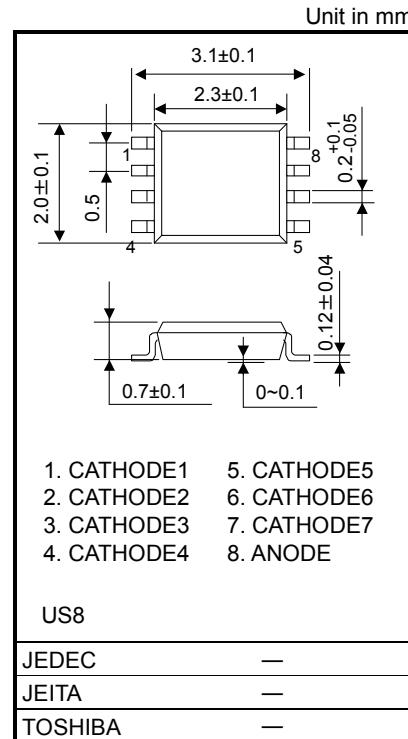
# DF8A6.2FK

## Diodes for Protecting Against ESD

- Because seven devices are mounted on an ultra compact package, it is possible to allow reducing the number of the parts and the mounting cost.
- Zener voltage correspond to E24 series.

### Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit
Power dissipation	P	200	mW
Junction temperature	T <sub>j</sub>	150	°C
Storage temperature range	T <sub>stg</sub>	-55~150	°C



### Electrical Characteristics (Ta = 25°C)

US8  
JEDEC —  
JEITA —  
TOSHIBA —  
Weight: 0.0088g(typ.)

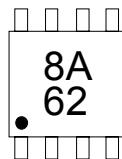
Characteristic	Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit
Zener voltage	V <sub>Z</sub>	—	I <sub>Z</sub> = 5mA	5.8	6.2	6.6	V
Dynamic impedance	Z <sub>Z</sub>	—	I <sub>Z</sub> = 5mA	—	—	30	Ω
Reverse current	I <sub>R</sub>	—	V <sub>R</sub> = 3V	—	—	1.0	μA
Total capacitance	C <sub>T</sub>	—	V <sub>R</sub> = 0V, f=1MHz	—	55	—	pF

### Guaranteed Level of ESD Immunity

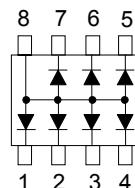
Test Condition	ESD Immunity Level
IEC61000-4-2 (Contact discharge)	± 30kV

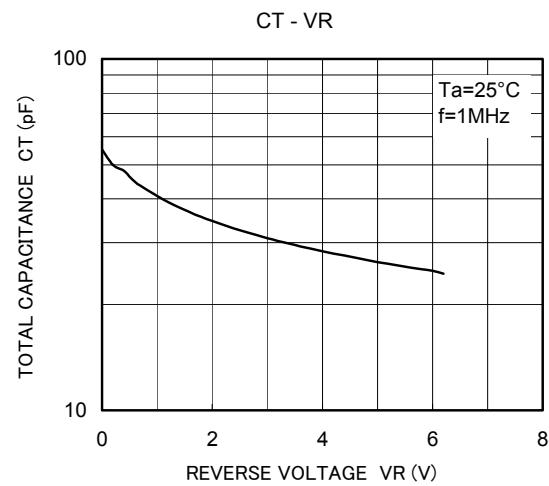
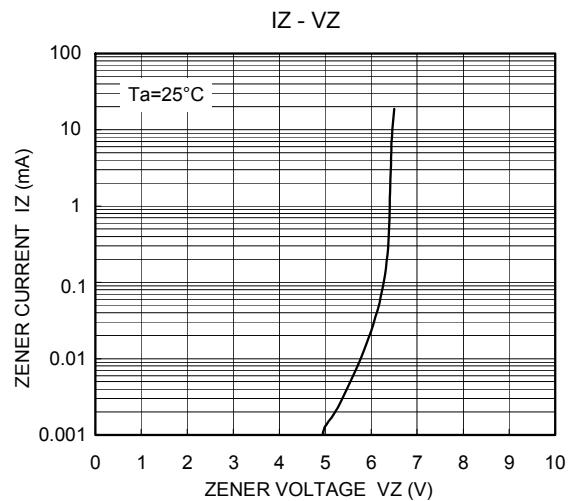
Judgment contents : No element destruction

### Marking



### Equivalent Circuit (Top View)





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